


<b>Search Notes</b>  	<b>Application/Control No.</b>  10577063	<b>Applicant(s)/Patent Under Reexamination</b>  BITAR ET AL.
	<b>Examiner</b>  STEPHEN R KOZIOL	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	181, 283	9/3/2008	SRK

SEARCH NOTES		
Search Notes	Date	Examiner
PALM inventor name double patenting search	9/3/2008	SRK
EAST text search of above-cited classes for determining optimal coefficients in a Chamfer mask	9/3/2008	SRK
IEEE Transactions on Image Processing search for Chamfer mask coefficient determination	9/3/2008	SRK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/S. R. K./  
Examiner, Art Unit 2624